

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/083,541	NAKAJIMA ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Tran Q. Le	2633	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0039217	04-2002	Saunders et al.	359/161
	B	US-6,437,892	08-2002	Fang et al.	398/152
	C	US-6,459,518	10-2002	Suzuki et al.	398/152
	D	US-2004/0161245	08-2004	Bergano, Neal S.	398/186
	E	US-5,295,013	03-1994	Ono, Takashi	398/205
	F	US-2002/0060822	05-2002	Wedding, Berthold	359/124
	G	US-5,023,948	06-1991	Smith, David W.	398/185
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.